


<b>Search Notes</b>  	<b>Application/Control No.</b>  10568974	<b>Applicant(s)/Patent Under Reexamination</b>  CHEN ET AL.
	<b>Examiner</b>  Johnson, Ryan J	<b>Art Unit</b>  2817

SEARCHED			
Class	Subclass	Date	Examiner
331	5,86,88,90,91	1/4/2008	Ryan Johnson
313	433,153,156	1/4/2008	Ryan Johnson
315	5.13,39.51,39.63	1/4/2008	Ryan Johnson

SEARCH NOTES		
Search Notes	Date	Examiner
See EAST history	1/4/2008	Ryan Johnson
Google search	1/4/2008	Ryan Johnson
IEEE search	1/4/2008	Ryan Johnson
Emailed Joseph Chang	1/4/2008	Ryan Johnson

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner